

Sacrificial Layer Etching

Engineered for MEMS release using anhydrous HF to achieve uniform, stiction-free oxide removal.



Vetelgeuse

SPT's sacrificial layer etching system is optimized for MEMS release, enabling uniform and stiction-free removal of silicon dioxide using anhydrous HF. With high selectivity and stable process control, it supports reliable fabrication of complex MEMS structures.

Applications:

- ✓ MEMS Devices

FEATURES

Why Choose SPT for High-Precision Sacrificial Layer Etching



Aluminum-Compatible Etching

Supports oxide removal in MEMS structures with aluminum, without corrosion or damage—ideal for CMOS-compatible designs.



Extended Undercut Capability

Enables precise sacrificial etching with extended undercut lengths, supporting both micron-scale features and millimeter-range cavities.



Clean and Stable Dry Process

Uses vapor-phase etching to eliminate liquid waste and reduce tool downtime, offering stable performance with low environmental impact.



Flexible System Configuration

Available in manual, load-lock, and cluster configurations to meet various fab needs from prototype development to high-volume manufacturing.

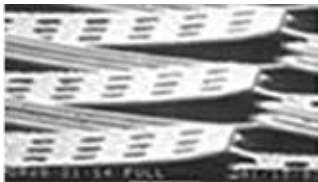


High Selectivity and Process Control

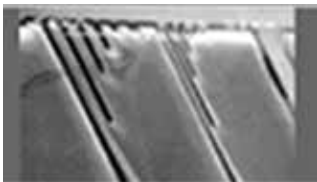
Delivers precise control over etch depth and selectivity between oxide and structural layers, ensuring process repeatability for MEMS devices.

PERFORMANCE

Performance for Reliable MEMS Release and Structural Integrity



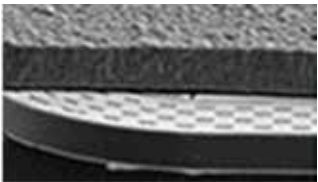
Infrared Bolometer Structure



Cantilever Structure



SOI Wafer BOX Layer Release



Silicon Oscillator Structure (Courtesy of SiTime)

Specification

Process Module



Wafer size (mm)	200
Platform	VPX
Etching Speed	Medium
Substrates	SiO ₂
Application	MEMS

Platform



Intended Use	Small Volume
Number of Chambers	3
Cassette Transfer Robot	Vacuum
Robot Motion	3-Axis
Number of Cassette Stations	1

